

International Rectifier

PD - 95147

IRFZ24NS/LPbF

HEXFET® Power MOSFET

- Advanced Process Technology
- Surface Mount (IRFZ24NS)
- Low-profile through-hole (IRFZ24NL)
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D²Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

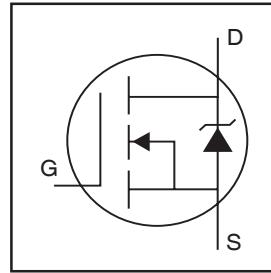
The through-hole version (IRFZ24NL) is available for low-profile applications.

Absolute Maximum Ratings

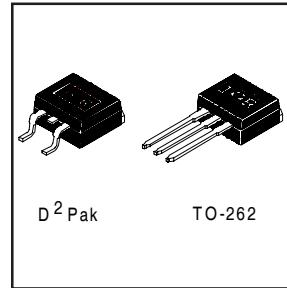
	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V ^⑤	17	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V ^⑤	12	A
I _{DM}	Pulsed Drain Current ①⑤	68	
P _D @ T _A = 25°C	Power Dissipation	3.8	W
P _D @ T _C = 25°C	Power Dissipation	45	W
	Linear Derating Factor	0.30	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy ^{②⑤}	71	mJ
I _{AR}	Avalanche Current ^①	10	A
E _{AR}	Repetitive Avalanche Energy ^①	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt ^{③⑤}	6.8	V/ns
T _J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
R _{θJC}	Junction-to-Case	—	3.3	°C/W
R _{θJA}	Junction-to-Ambient (PCB Mounted,steady-state)**	—	40	



V_{DSS} = 55V
R_{DS(on)} = 0.07Ω
I_D = 17A



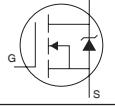
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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	55	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.052	—	V°C	Reference to 25°C , $I_D = 1\text{mA}$ ^⑤
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.07	Ω	$V_{\text{GS}} = 10\text{V}$, $I_D = 10\text{A}$ ^④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = 250\mu\text{A}$
g_{fs}	Forward Transconductance	4.5	—	—	S	$V_{\text{DS}} = 25\text{V}$, $I_D = 10\text{A}$ ^⑤
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{\text{DS}} = 55\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 44\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -20\text{V}$
Q_g	Total Gate Charge	—	—	20	nC	$I_D = 10\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	5.3		$V_{\text{DS}} = 44\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	7.6		$V_{\text{GS}} = 10\text{V}$, See Fig. 6 and 13 ^{④⑤}
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	4.9	—	ns	$V_{\text{DD}} = 28\text{V}$
t_r	Rise Time	—	34	—		$I_D = 10\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	19	—		$R_G = 24\Omega$
t_f	Fall Time	—	27	—		$R_D = 2.6\Omega$, See Fig. 10 ^{④⑤}
L_s	Internal Source Inductance	—	7.5	—	nH	Between lead, and center of die contact
C_{iss}	Input Capacitance	—	370	—	pF	$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance	—	140	—		$V_{\text{DS}} = 25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	65	—		$f = 1.0\text{MHz}$, See Fig. 5 ^⑤

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	17	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ^①	—	—	68		
V_{SD}	Diode Forward Voltage	—	—	1.3		$T_J = 25^\circ\text{C}$, $I_S = 10\text{A}$, $V_{\text{GS}} = 0\text{V}$ ^④
t_{rr}	Reverse Recovery Time	—	56	83	ns	$T_J = 25^\circ\text{C}$, $I_F = 10\text{A}$
Q_{rr}	Reverse Recovery Charge	—	120	180	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ^{④⑤}
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting $T_J = 25^\circ\text{C}$, $L = 1.0\text{mH}$
 $R_G = 25\Omega$, $I_{AS} = 10\text{A}$. (See Figure 12)
- ③ $I_{SD} \leq 10\text{A}$, $dI/dt \leq 280\text{A}/\mu\text{s}$, $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$,
 $T_J \leq 175^\circ\text{C}$
- ④ Pulse width $\leq 280\mu\text{s}$; duty cycle $\leq 2\%$.
- ⑤ Uses IRFZ24N data and test conditions

** When mounted on 1" square PCB (FR-4 or G-10 Material).
For recommended footprint and soldering techniques refer to application note #AN-994.

IRFZ24NS/LPbF

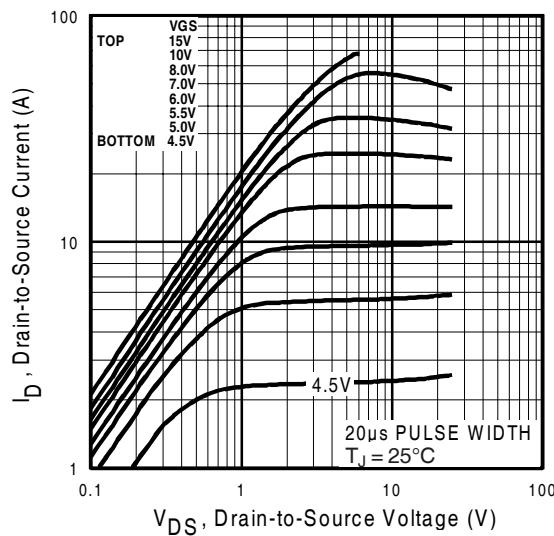


Fig 1. Typical Output Characteristics

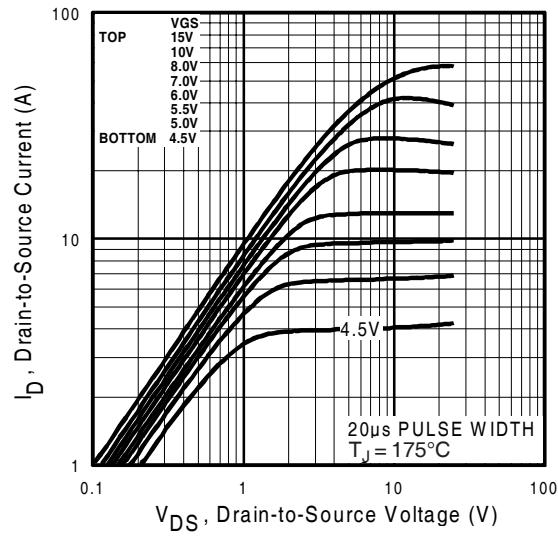


Fig 2. Typical Output Characteristics

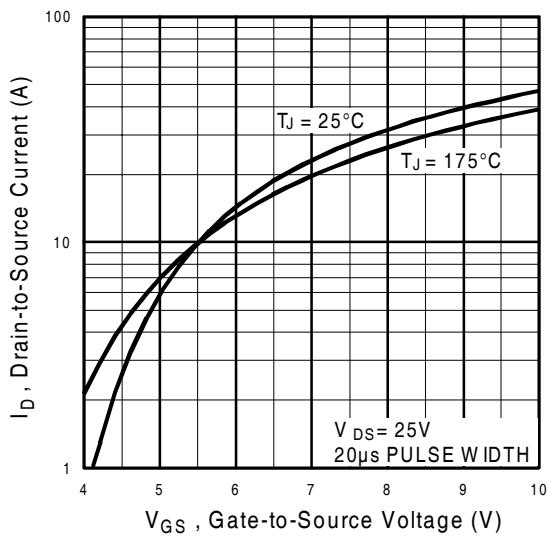


Fig 3. Typical Transfer Characteristics

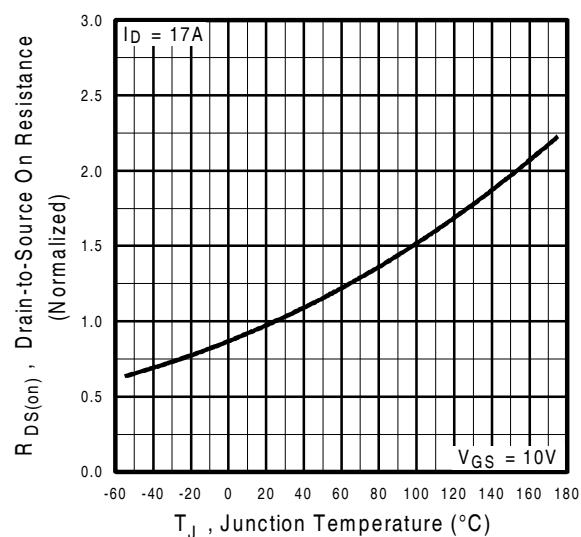


Fig 4. Normalized On-Resistance
Vs. Temperature

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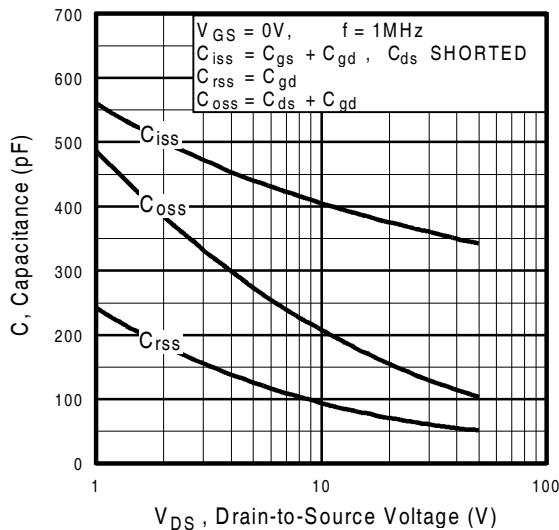


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

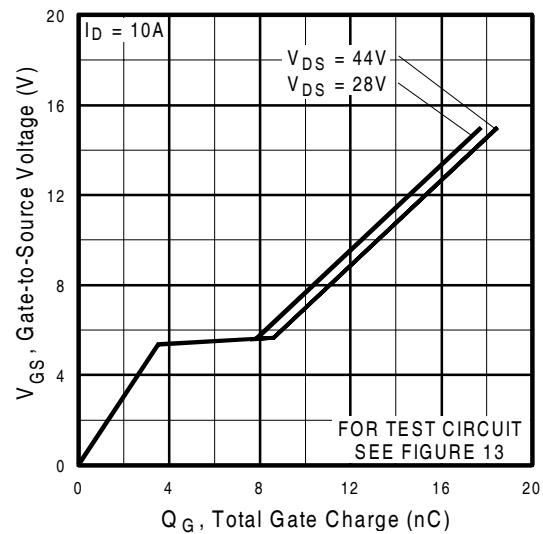


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

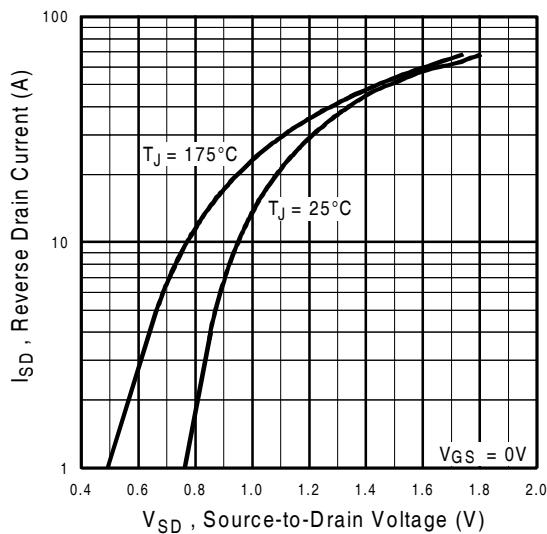


Fig 7. Typical Source-Drain Diode
Forward Voltage

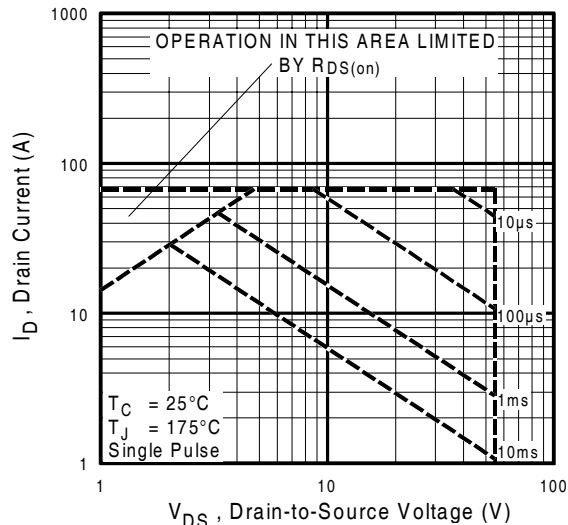


Fig 8. Maximum Safe Operating Area

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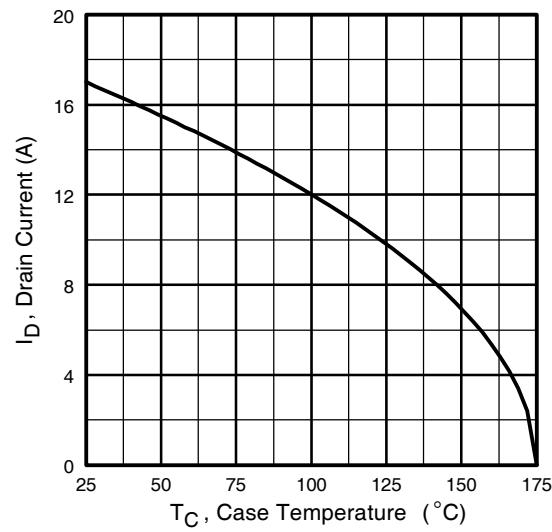


Fig 9. Maximum Drain Current Vs.
Case Temperature

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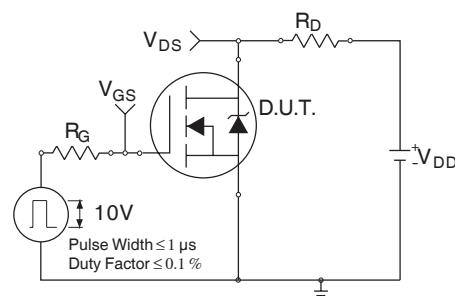


Fig 10a. Switching Time Test Circuit

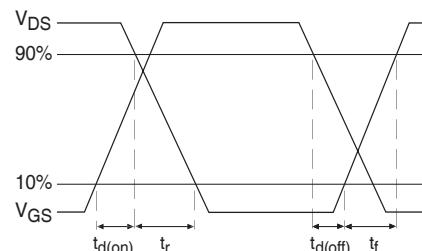


Fig 10b. Switching Time Waveforms

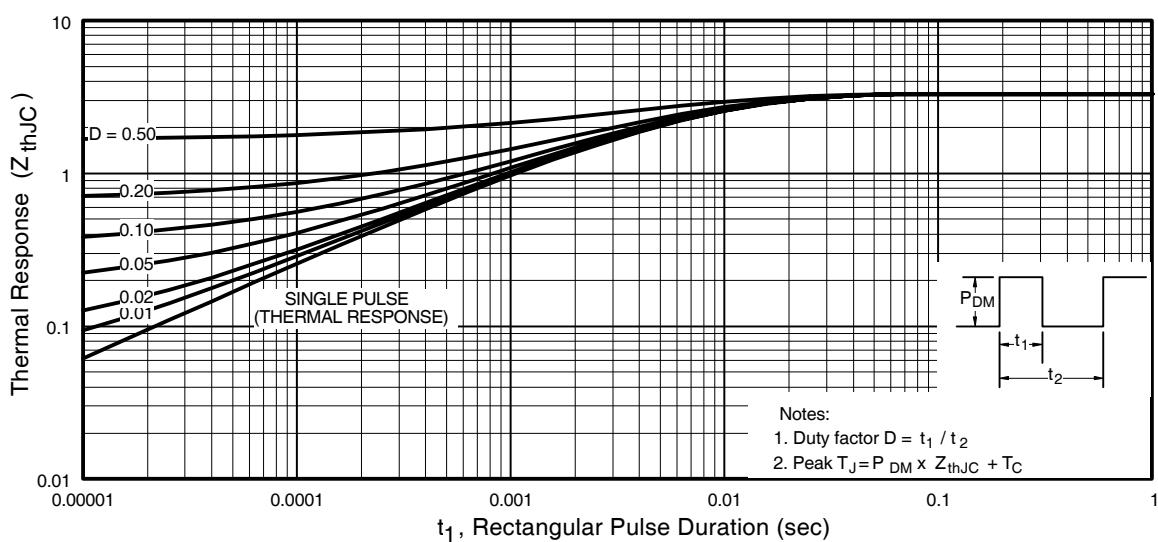


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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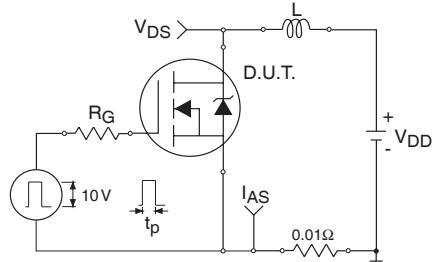


Fig 12a. Unclamped Inductive Test Circuit

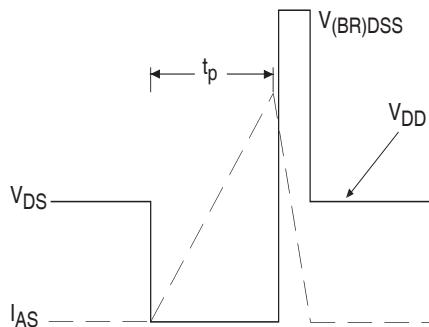


Fig 12b. Unclamped Inductive Waveforms

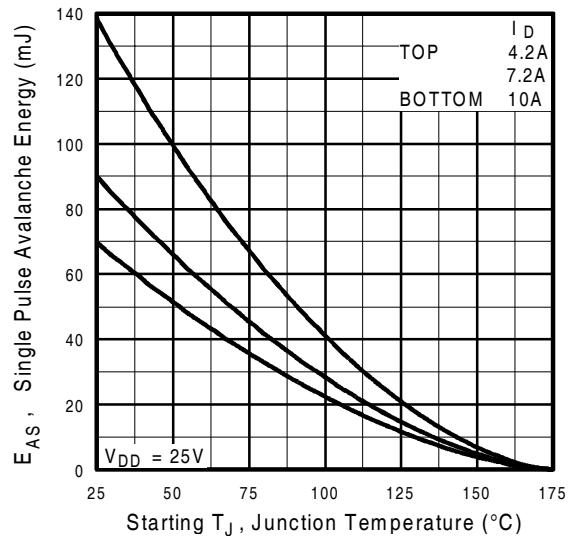


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

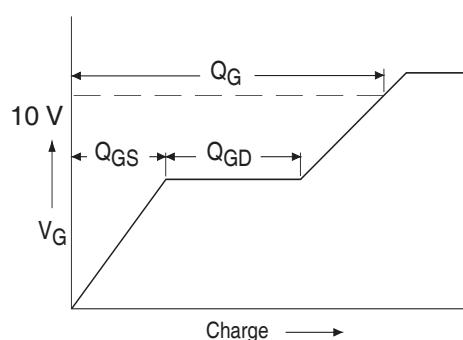


Fig 13a. Basic Gate Charge Waveform

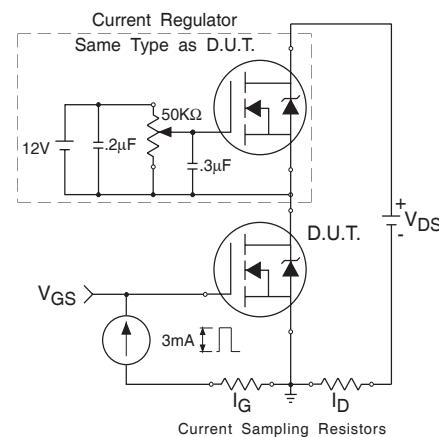
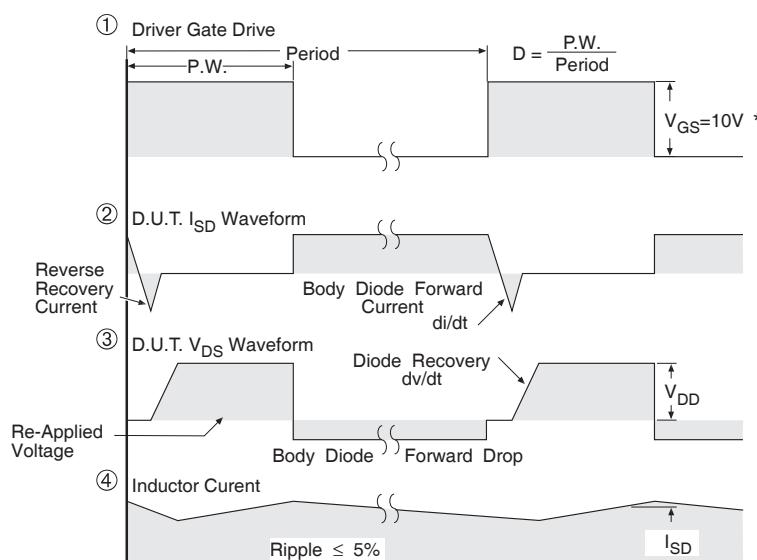
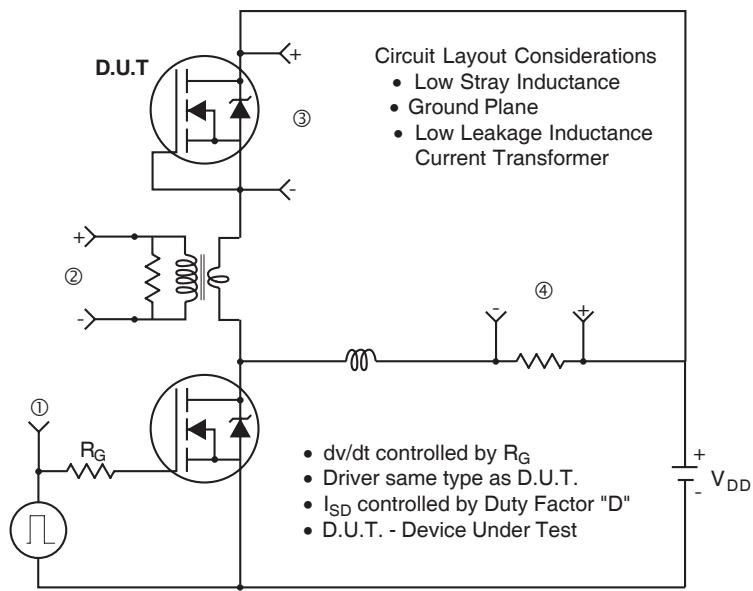


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



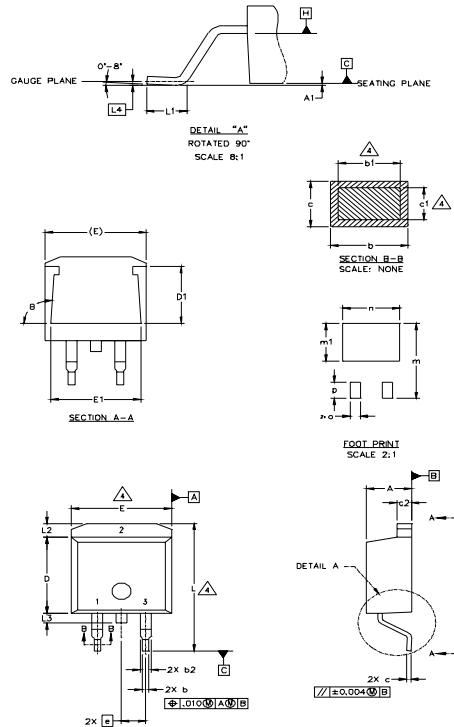
* $V_{GS} = 5V$ for Logic Level Devices

Fig 14. For N-Channel HEXFETS

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D²Pak Package Outline



SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	4.06	4.83	.160	.190		
A1			.0127	.005		
b	0.51	0.99	.020	.039	4	
b1	0.51	0.89	.020	.035		
b2	1.14	1.40	.045	.055		
c	0.43	0.63	.017	.025		
c1	0.38	0.74	.015	.029	4	
c2	1.14	1.40	.045	.055		
D	8.51	9.65	.335	.380	3	
D1	5.33		.210			
E	9.65	10.67	.380	.420	3	
E1	6.22		.245			
e	2.54	BSC	.100	BSC		
L	14.61	15.88	.575	.625		
L1	1.78	2.79	.070	.110		
L2			1.65	.065		
L3	1.27	1.78	.050	.070		
L4	0.25	BSC	.010	BSC		
m	17.78		.700			
m1	8.89		.350			
n	11.43		.450			
o	2.08		.082			
p	3.81		.150			
θ	90°	93°	90°	93°		

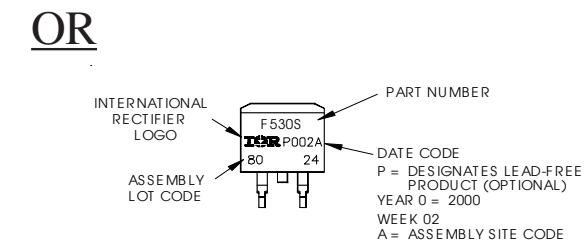
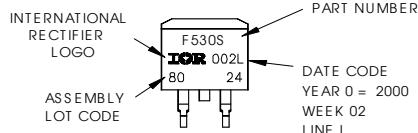
LEAD ASSIGNMENTS

HEXFET	IGBTs, CoPACK	DIODES
1.— GATE 2.— DRAIN 3.— SOURCE	1.— GATE 2.— COLLECTOR 3.— Emitter	1.— ANODE * 2.— CATHODE 3.— ANODE

* PART DEPENDENT.

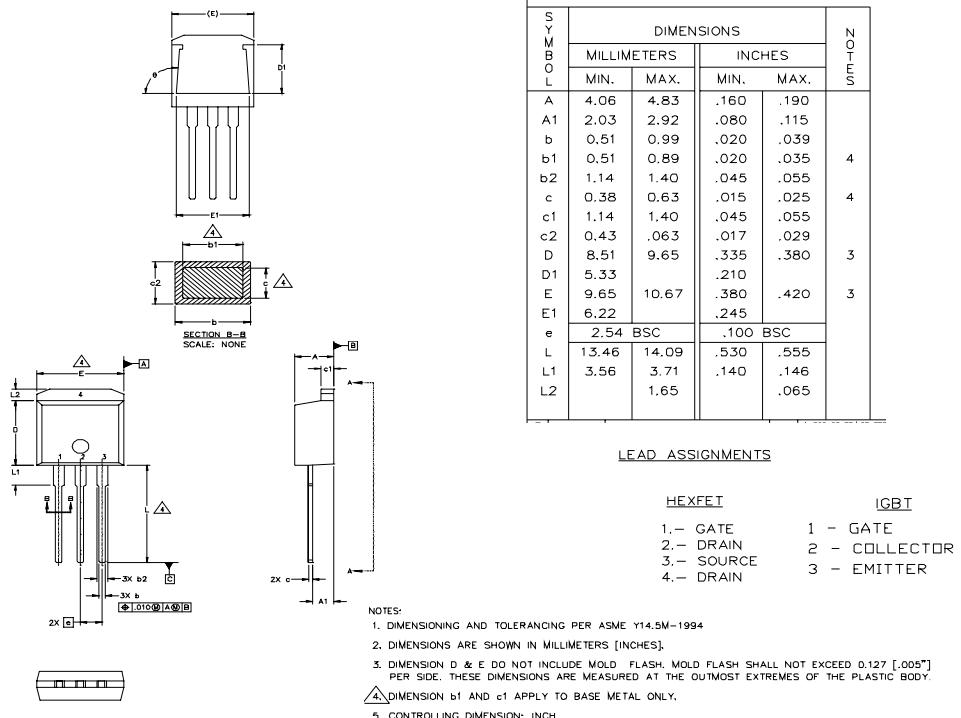
- NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
 4. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
 5. CONTROLLING DIMENSION: INCH.

EXAMPLE: THIS IS AN IRF530S WITH
LOT CODE 8024
ASSEMBLED ON WW 02, 2000
IN THE ASSEMBLY LINE "L"
Note: "P" In assembly line
position indicates "Lead-Free"



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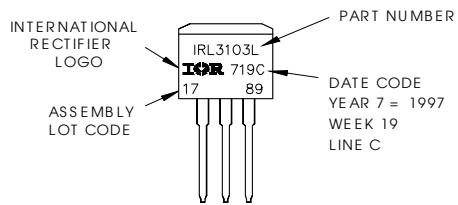
TO-262 Package Outline



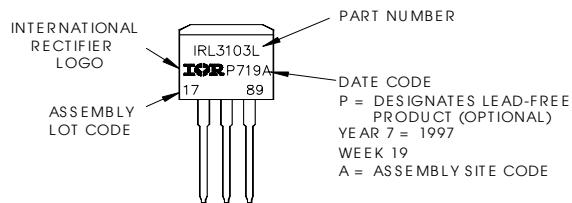
TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L
LOT CODE 1789
ASSEMBLED ON WW 19, 1997
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line
position indicates "Lead-Free"



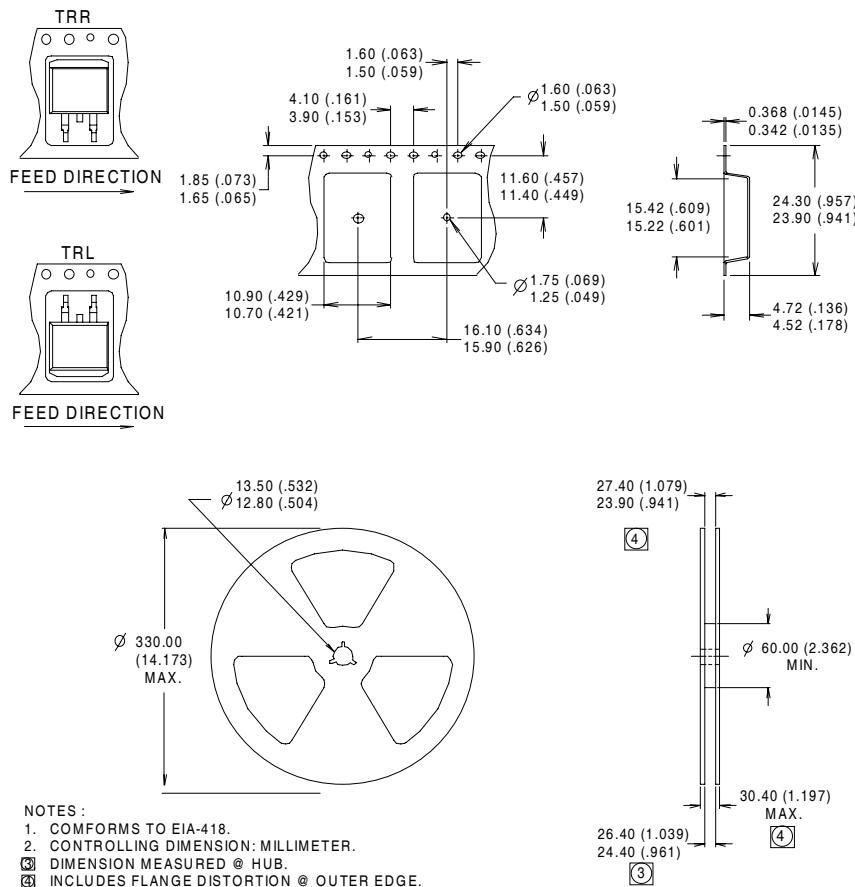
OR



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D²Pak Tape & Reel Information



Data and specifications subject to change without notice.

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TAC Fax: (310) 252-7903
Visit us at www.irf.com for sales contact information. 04/04

Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>

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